Notice of References Cited Application/Control No. 10/520,618 Examiner Edu E. Enin-Okut Applicant(s)/Patent Under Reexamination AOKI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,727,014	04-2004	Wilson et al.	429/26
	В	US-			
	O	US-			
	ם	US-			
	ш	US-			
	F	US-			
	O	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	EP 1 298 745 A2	04-2003	European Patent	YOSHIDA et al.	H01M 4/86
	0	WO 01/04980 A1	01-2001	WIPO	Trapp et al.	H01M 4/96
	Ρ					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	C						
	>						
	w						
	х						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.